

APPLICANT

REPORT No.: SZ23020101E03

# **TEST REPORT**

: Feit Electric Company Inc.

PRODUCT NAME	. Integral Antenna	
MODEL NAME	: Driver-117	
TRADE NAME	: Feit, Naspil	
BRAND NAME	: N/A	
STANDARD(S)	: IEEE Std 149-2021	
RECEIPT DATE	: 2023-02-08	
TEST DATE	: 2023-02-09	
ISSUE DATE	: 2023-03-15	
	Edited by:	Fang Jinshan
		Fang Jinshan(Rapporteur)
	Approved by	Con Grade

NOTE: This document is issued by Shenzhen Morlab Communications Technology Co., Ltd., the test report shall not be reproduced except in full without prior written permission of the company. The test results apply only to the particular sample(s) tested and to the specific tests carried out which is available on request for validation and information confirmed at our website.

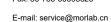


Tel: 86-755-36698555

Chi Shide(Supervisor)

Fax: 86-755-36698525

Http://www.morlab.cn







## **DIRECTORY**

1. Technical Informa	ation ·····		3
1.1. Applicant and M	lanufacturer Informat	ion	. 3
1.2. Equipment Und	er Test (EUT) Descrip	tion ·····	3
2. Test Results ·······			4
2.1. Applied Referer	nce Documents		٠4
2.2. Test Conditions			4
2.3. Measurement U	ncertainty ·····		4
2.4. Test Results ·····			5
2.4.1.Gain			5
2.4.2.VSWR			5
2.4.3.Return Loss ·····			.6
Annex A Test Setup	Photos ·····		7
_			
•			
		- 1	
		- 1	
		ting Laboratory·······1	
	-	ting Location····································	
	•	-	
i.o iest Equipment	5 Ullizeu	1	. 3
	Change	History	
Version	Date	Reason for change	
1.0	2023-03-15	First edition	



## 1.Technical Information

Note: Provide by applicant.

## 1.1. Applicant and Manufacturer Information

Applicant:	Feit Electric Company Inc.
Applicant Address:	4901 Gregg Road Pico Rivera, Ca 90660
Manufacturer:	National State Industries Limited
Manufacturer Address:	XinXing Group, WuLian Village, FengGang Town, DongGuan City, Guangdong Province, 523695 China

## 1.2. Equipment Under Test (EUT) Description

Wireless Type	N/A
Frequency	N/A
IMEI	N/A
Sample No.	3#





2. Test Results

## 2.1. Applied Reference Documents

Leading reference documents for testing:

No.	Identity	Document Title
1	IEEE Std 149-2021	IEEE Recommended Practice for Antenna
		Measurements

#### 2.2. Test Conditions

**Test Environment Conditions:** 

Relative Humidity:	25 75 %
Temperature:	+10 °C to +30 °C

### 2.3. Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO. When the test result is a critical value, we will use the measurement uncertainty give the judgment result based on the 95% Confidence intervals.

Item	Measurement Uncertainty(dB)	
Gain	±0.5	
VSWR	±0.2	
Measurement Uncertainty(95% Confidence Interval) K=2		



REPORT No.: SZ23020101E03



### 2.4. Test Results

### 2.4.1.Gain

Frequency (MHz)	Gain(dBi)
2400	-3.45
2410	-3.62
2420	-3.88
2430	-4.01
2440	-3.82
2450	-3.84
2460	-4.05
2470	-4.20
2480	-4.15
2490	-3.91
2500	-3.59

### 2.4.2.VSWR

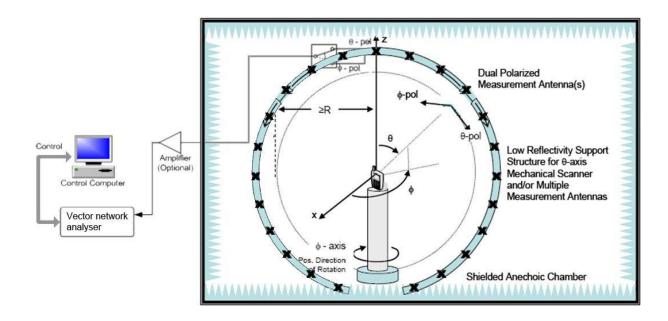
Frequency	VSWR
2400MHz	8.95
2440MHz	8.67
2480MHz	8.13



Frequency (MHz)	Return Loss (dB)
2400	-1.94
2440	-2.01
2480	-2.14



## Annex A Test Setup Photos



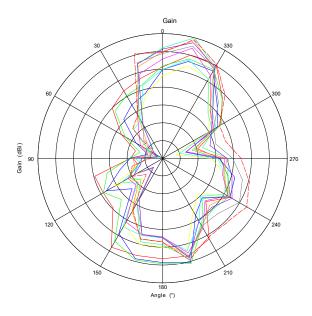




## Annex B Figures

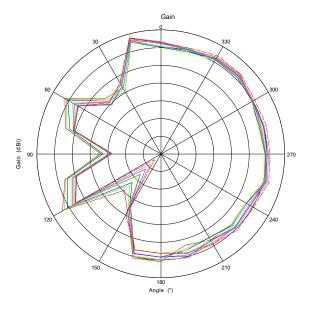
### 1. 2D Radiation Pattern

#### Phi=0°



Max: -5 Min: -8.5 Scale: 0.5/div

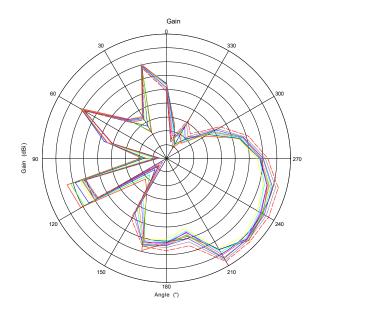
#### Phi=90°



Max: -4 Min: -18 Scale: 2/div

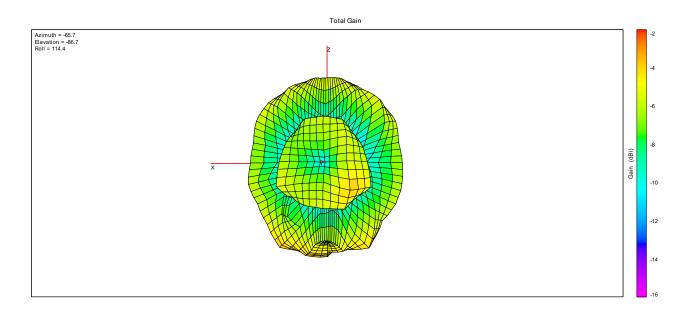






Min: -13 Scale: 1/div

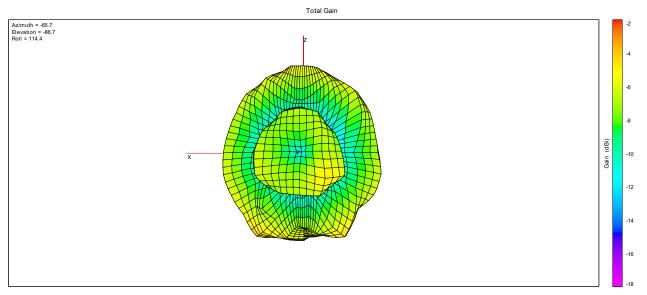
#### 2. 3D Radiation Pattern



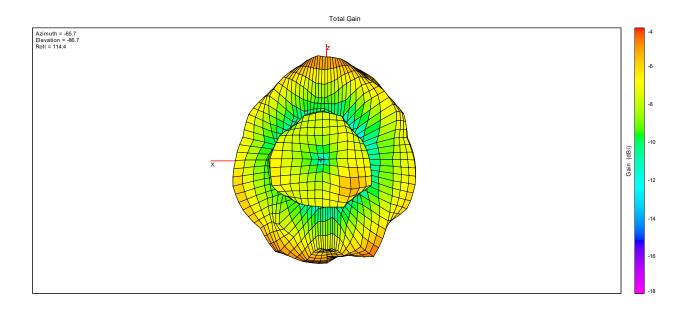
2400MHz







#### 2440MHz

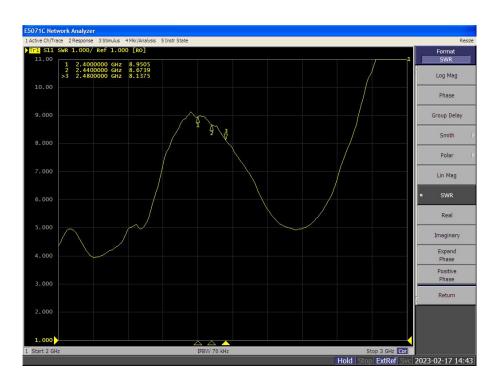


#### 2480MHz

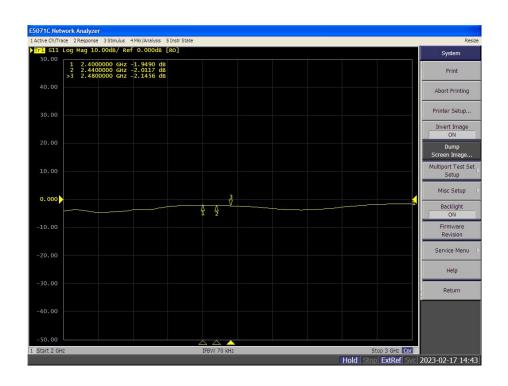




#### 3. VSWR



### 4. Return Loss

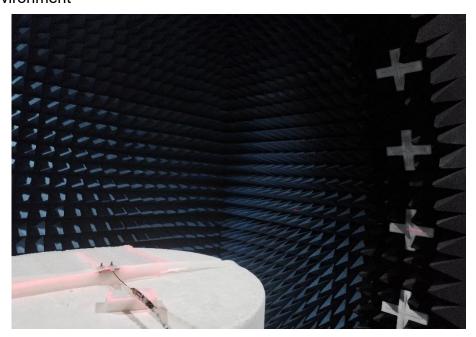


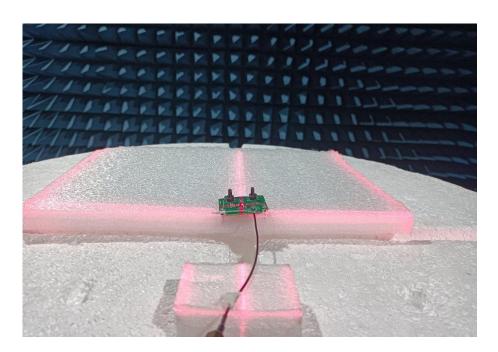




#### Annex C EUT Photos

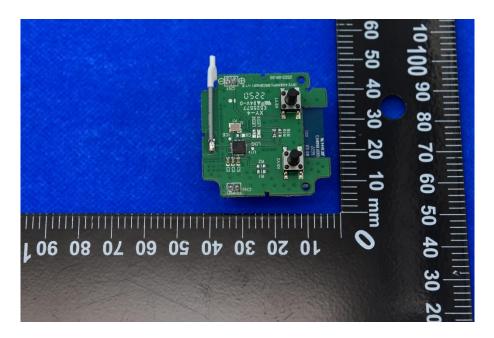
#### 1. Test environment

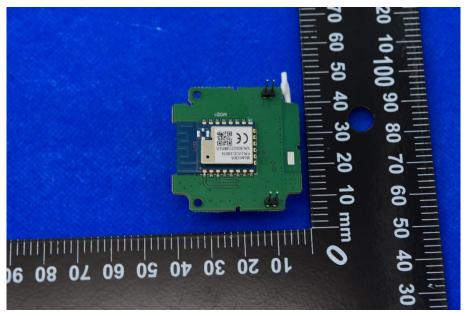




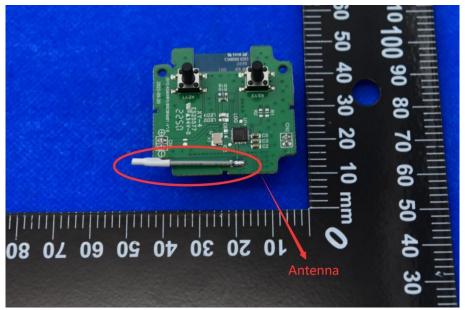


#### 2. EUT













#### **General Information** Annex D

## 1.1 Identification of the Responsible Testing Laboratory

Laboratory Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Laboratory Address:	FL.1-3, Building A, FeiYang Science Park, No.8
	LongChang Road, Block67, BaoAn District, ShenZhen,
	GuangDong Province, P. R. China
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

## 1.2 Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Address:	FL.1-3, Building A, FeiYang Science Park, No.8
	LongChang Road, Block67, BaoAn District, ShenZhen,
	GuangDong Province, P. R. China

## 1.3 Test Equipments Utilized

No	Equipement Name	Serial No.	Type	Manufacturer	Cal.Date	Cal.Due Date
1	Network	MY46110140	E5071C	Agilent	2022.07.04	2023.07.03
	Analyzer					
2	OTA Chamber	TJ2235-Q1793	AMS-892	ETS	2022.11.30	2025.11.29
			3-150			
3			EMQuest			
	Antenna	1685	EMQ-100	ETS	N/A	N/A
	Measurement		V 1.13			
	System		Build			
			21267			



FeiYang Science Park, No.8 LongChang Road, Block67, BaoAn District,

ShenZhen , GuangDong Province, P. R. China

